

## MOSFET

### 600V CoolMOS™ PFD7 SJ Power Device

CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies.

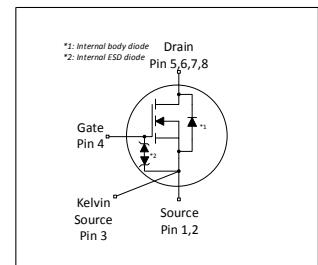
The latest CoolMOS™ PFD7 is an optimized platform tailored to target cost sensitive applications in consumer markets such as charger, adapter, motor drive, lighting, etc.

The new series provides all the benefits of a fast switching Superjunction MOSFET, combined with an excellent price/performance ratio and state of the art ease-of-use level. The technology meets highest efficiency standards and supports high power density, enabling customers going towards very slim designs.



### Features

- Extremely low losses due to very low FOM  $R_{DS(on)} \cdot Q_g$  and  $R_{DS(on)} \cdot E_{oss}$
- Low switching losses  $E_{oss}$ , excellent thermal behavior
- Fast body diode
- Wide range portfolio of  $R_{DS(on)}$  and package variations
- Integrated zener diode



### Benefits

- Enables high power density designs and small form factors
- Enables efficiency gains at higher switching frequencies
- Excellent commutation ruggedness
- Easy to select right parts and optimize the design
- High ESD ruggedness



### Potential applications

Recommended for ZVS topologies used in high density chargers, adapters, lighting and motor drives applications, etc.



### Product validation

Fully qualified according to JEDEC for Industrial Applications

*Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.*

**Table 1 Key Performance Parameters**

Parameter	Value	Unit
$V_{DS} @ T_{j,max}$	650	V
$R_{DS(on),max}$	360	$m\Omega$
$Q_{g,typ}$	12.7	nC
$I_{D,pulse}$	24	A
$E_{oss} @ 400V$	1.6	$\mu J$
Body diode $dI_F/dt$	1300	$A/\mu s$
ESD Class (HBM)	2	-

Type / Ordering Code	Package	Marking	Related Links
IPLK60R360PFD7	ThinPAK 5x6 SMD	60R360D7	see Appendix A

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## 1 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$	-	-	13 8	A	$T_C=25^\circ\text{C}$ $T_C=100^\circ\text{C}$
Pulsed drain current <sup>2)</sup>	$I_{D,\text{pulse}}$	-	-	24	A	$T_C=25^\circ\text{C}$
Avalanche energy, single pulse	$E_{AS}$	-	-	29	mJ	$I_D=2.1\text{A}; V_{DD}=50\text{V}$ ; see table 10
Avalanche energy, repetitive	$E_{AR}$	-	-	0.14	mJ	$I_D=2.1\text{A}; V_{DD}=50\text{V}$ ; see table 10
Avalanche current, single pulse	$I_{AS}$	-	-	2.1	A	-
MOSFET dv/dt ruggedness	dv/dt	-	-	120	V/ns	$V_{DS}=0\ldots 400\text{V}$
Gate source voltage (static)	$V_{GS}$	-20	-	20	V	static;
Gate source voltage (dynamic)	$V_{GS}$	-30	-	30	V	AC ( $f > 1 \text{ Hz}$ )
Power dissipation	$P_{tot}$	-	-	74	W	$T_C=25^\circ\text{C}$
Storage temperature	$T_{stg}$	-55	-	150	$^\circ\text{C}$	-
Operating junction temperature	$T_j$	-55	-	150	$^\circ\text{C}$	-
Mounting torque	-	-	-	-	Ncm	-
Continuous diode forward current <sup>1)</sup>	$I_S$	-	-	13	A	$T_C=25^\circ\text{C}$
Diode pulse current <sup>2)</sup>	$I_{S,\text{pulse}}$	-	-	24	A	$T_C=25^\circ\text{C}$
Reverse diode dv/dt <sup>3)</sup>	dv/dt	-	-	70	V/ns	$V_{DS}=0\ldots 400\text{V}, I_{SD}\leq 9.3\text{A}, T_j=25^\circ\text{C}$ see table 8
Maximum diode commutation speed	di <sub>F</sub> /dt	-	-	1300	A/ $\mu\text{s}$	$V_{DS}=0\ldots 400\text{V}, I_{SD}\leq 9.3\text{A}, T_j=25^\circ\text{C}$ see table 8
Insulation withstand voltage	$V_{ISO}$	-	-	n.a.	V	$V_{rms}, T_C=25^\circ\text{C}, t=1\text{min}$

<sup>1)</sup> Limited by  $T_{j,\text{max}}$ . Maximum Duty Cycle D = 0.50

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,\text{max}}$

<sup>3)</sup> Identical low side and high side switch with identical  $R_G$

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	1.70	°C/W	-
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	80	°C/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version	$R_{thJA}$	-	35	62	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area for drain connection and cooling. PCB is vertical without air stream cooling.
Soldering temperature, wave & reflow soldering allowed	$T_{sold}$	-	-	260	°C	reflow MSL1

### 3 Electrical characteristics

at  $T_j=25^\circ\text{C}$ , unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	600	-	-	V	$V_{\text{GS}}=0\text{V}$ , $I_D=1\text{mA}$
Gate threshold voltage	$V_{(\text{GS})\text{th}}$	3.5	4	4.5	V	$V_{\text{DS}}=V_{\text{GS}}$ , $I_D=0.14\text{mA}$
Zero gate voltage drain current <sup>1)</sup>	$I_{\text{DSS}}$	-	-	1 37	$\mu\text{A}$	$V_{\text{DS}}=600\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_j=25^\circ\text{C}$ $V_{\text{DS}}=600\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_j=125^\circ\text{C}$
Gate-source leakage current	$I_{\text{GSS}}$	-	-	1000	nA	$V_{\text{GS}}=20\text{V}$ , $V_{\text{DS}}=0\text{V}$
Drain-source on-state resistance	$R_{\text{DS}(\text{on})}$	-	0.303 0.711	0.360 -	$\Omega$	$V_{\text{GS}}=10\text{V}$ , $I_D=2.9\text{A}$ , $T_j=25^\circ\text{C}$ $V_{\text{GS}}=10\text{V}$ , $I_D=2.9\text{A}$ , $T_j=150^\circ\text{C}$
Gate resistance	$R_G$	-	11.0	-	$\Omega$	f=1MHz, open drain

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	$C_{\text{iss}}$	-	534	-	pF	$V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=400\text{V}$ , f=250kHz
Output capacitance	$C_{\text{oss}}$	-	12	-	pF	$V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=400\text{V}$ , f=250kHz
Effective output capacitance, energy related <sup>2)</sup>	$C_{\text{o(er)}}$	-	20	-	pF	$V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=0\ldots400\text{V}$
Effective output capacitance, time related <sup>3)</sup>	$C_{\text{o(tr)}}$	-	187	-	pF	$I_D=\text{constant}$ , $V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=0\ldots400\text{V}$
Turn-on delay time	$t_{\text{d(on)}}$	-	13.5	-	ns	$V_{\text{DD}}=400\text{V}$ , $V_{\text{GS}}=10\text{V}$ , $I_D=2.9\text{A}$ , $R_G=10.2\Omega$ ; see table 9
Rise time	$t_r$	-	11	-	ns	$V_{\text{DD}}=400\text{V}$ , $V_{\text{GS}}=10\text{V}$ , $I_D=2.9\text{A}$ , $R_G=10.2\Omega$ ; see table 9
Turn-off delay time	$t_{\text{d(off)}}$	-	46	-	ns	$V_{\text{DD}}=400\text{V}$ , $V_{\text{GS}}=10\text{V}$ , $I_D=2.9\text{A}$ , $R_G=10.2\Omega$ ; see table 9
Fall time	$t_f$	-	13	-	ns	$V_{\text{DD}}=400\text{V}$ , $V_{\text{GS}}=10\text{V}$ , $I_D=2.9\text{A}$ , $R_G=10.2\Omega$ ; see table 9

**Table 6 Gate charge characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	$Q_{\text{gs}}$	-	3.0	-	nC	$V_{\text{DD}}=400\text{V}$ , $I_D=2.9\text{A}$ , $V_{\text{GS}}=0$ to $10\text{V}$
Gate to drain charge	$Q_{\text{gd}}$	-	4.4	-	nC	$V_{\text{DD}}=400\text{V}$ , $I_D=2.9\text{A}$ , $V_{\text{GS}}=0$ to $10\text{V}$
Gate charge total	$Q_g$	-	12.7	-	nC	$V_{\text{DD}}=400\text{V}$ , $I_D=2.9\text{A}$ , $V_{\text{GS}}=0$ to $10\text{V}$
Gate plateau voltage	$V_{\text{plateau}}$	-	5.6	-	V	$V_{\text{DD}}=400\text{V}$ , $I_D=2.9\text{A}$ , $V_{\text{GS}}=0$ to $10\text{V}$

<sup>1)</sup> Maximum specification is defined by calculated six sigma upper confidence bound

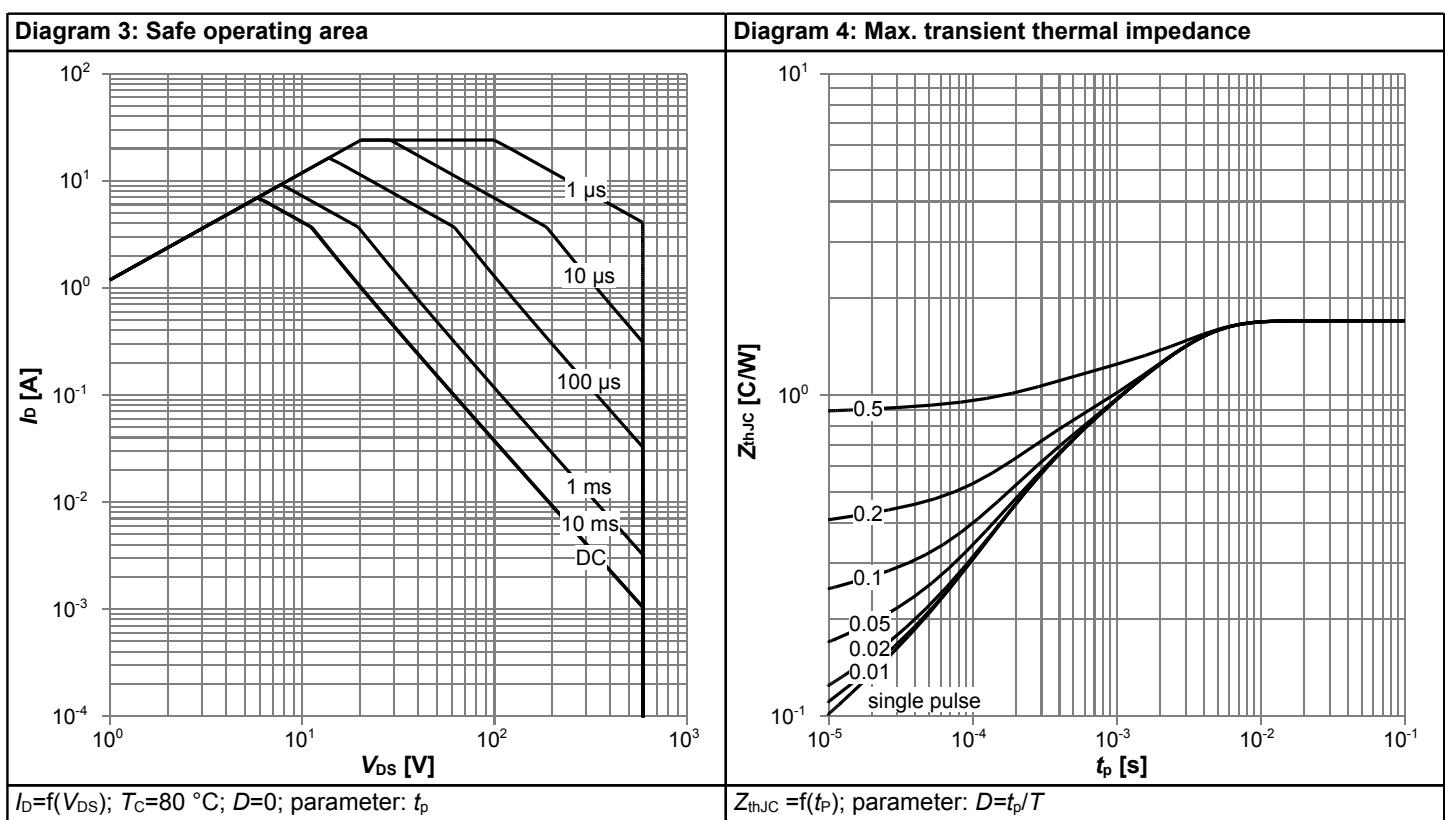
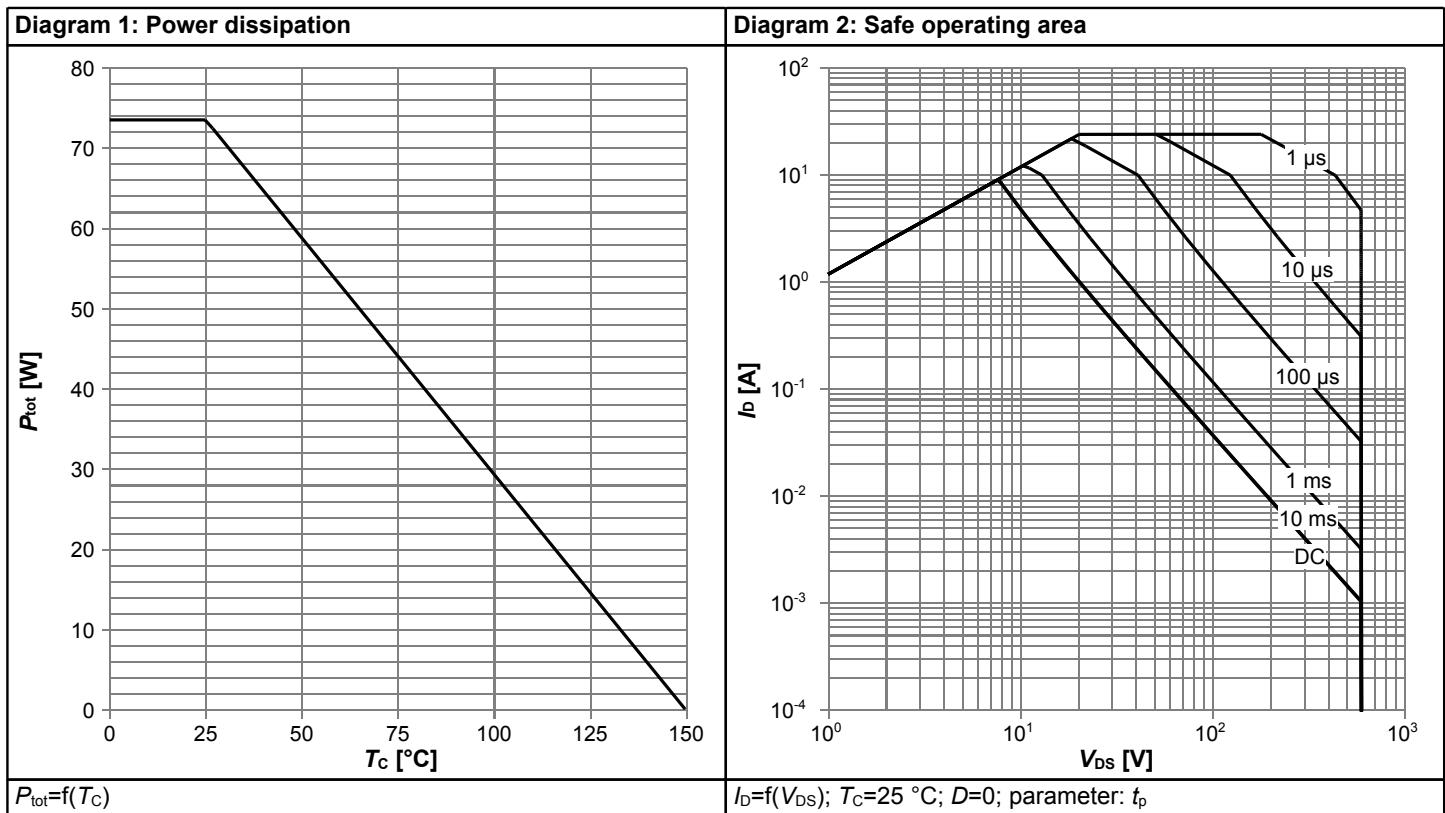
<sup>2)</sup>  $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V

<sup>3)</sup>  $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 400V

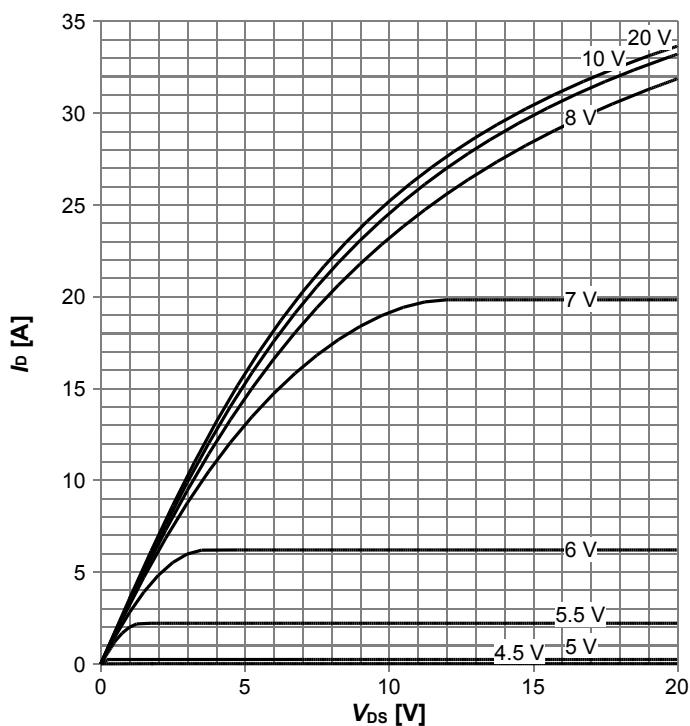
**Table 7 Reverse diode characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	$V_{SD}$	-	1.0	-	V	$V_{GS}=0V$ , $I_F=2.9A$ , $T_J=25^\circ C$
Reverse recovery time	$t_{rr}$	-	60	90	ns	$V_R=400V$ , $I_F=2.9A$ , $di_F/dt=100A/\mu s$ ; see table 8
Reverse recovery charge	$Q_{rr}$	-	0.14	0.28	$\mu C$	$V_R=400V$ , $I_F=2.9A$ , $di_F/dt=100A/\mu s$ ; see table 8
Peak reverse recovery current	$I_{rrm}$	-	4.1	-	A	$V_R=400V$ , $I_F=2.9A$ , $di_F/dt=100A/\mu s$ ; see table 8

## 4 Electrical characteristics diagrams

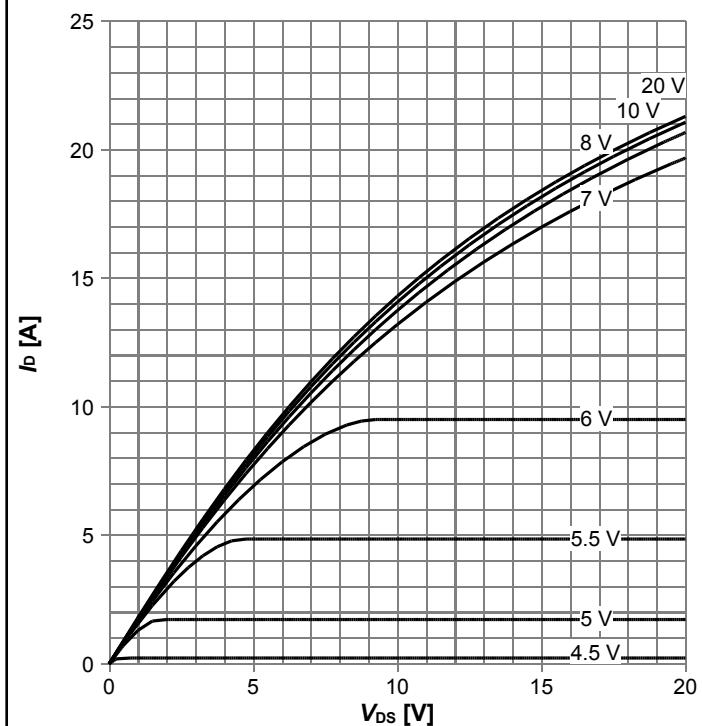


**Diagram 5: Typ. output characteristics**



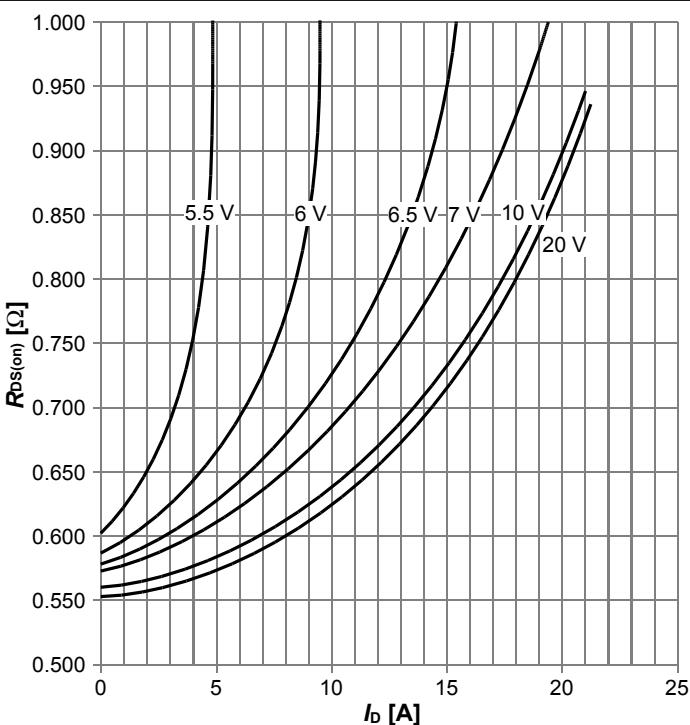
$I_D=f(V_{DS})$ ;  $T_j=25\text{ }^\circ\text{C}$ ; parameter:  $V_{GS}$

**Diagram 6: Typ. output characteristics**



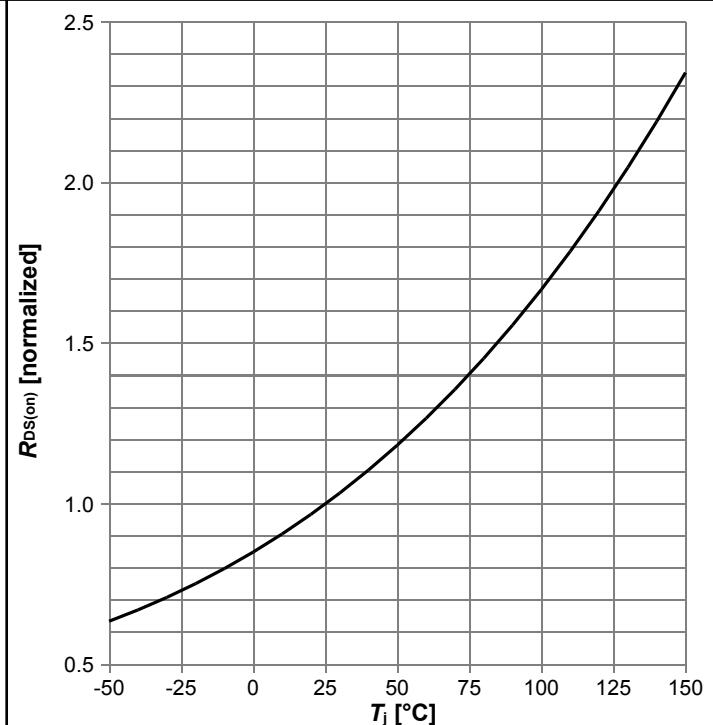
$I_D=f(V_{DS})$ ;  $T_j=125\text{ }^\circ\text{C}$ ; parameter:  $V_{GS}$

**Diagram 7: Typ. drain-source on-state resistance**



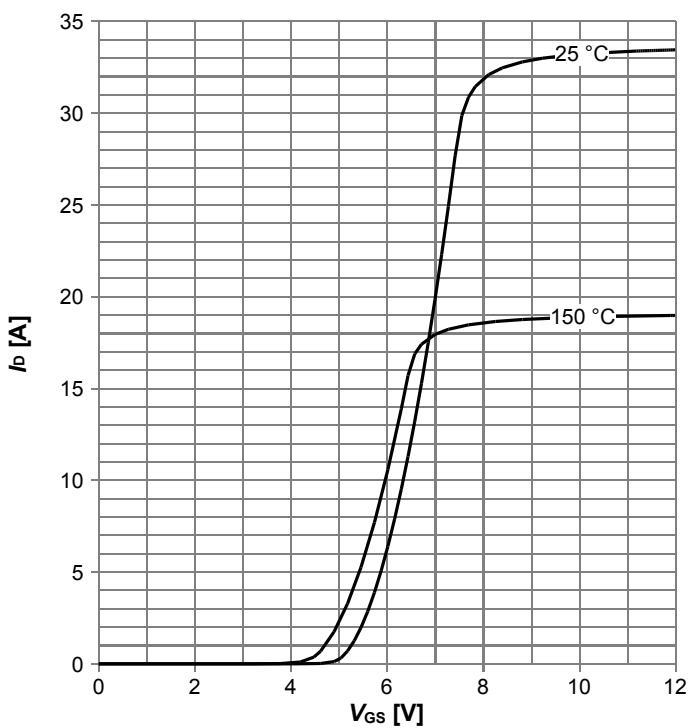
$R_{DS(on)}=f(I_D)$ ;  $T_j=125\text{ }^\circ\text{C}$ ; parameter:  $V_{GS}$

**Diagram 8: Drain-source on-state resistance**



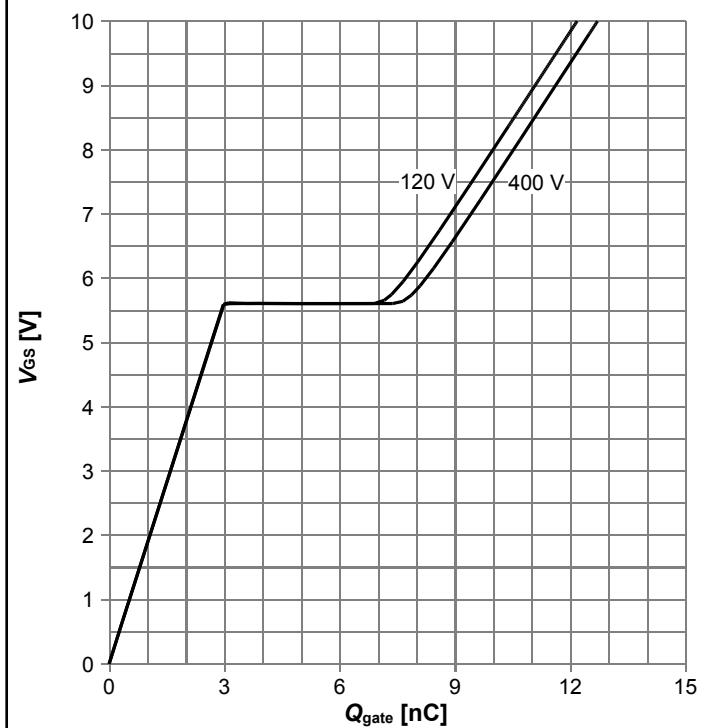
$R_{DS(on)}=f(T_j)$ ;  $I_D=2.9\text{ A}$ ;  $V_{GS}=10\text{ V}$

**Diagram 9: Typ. transfer characteristics**



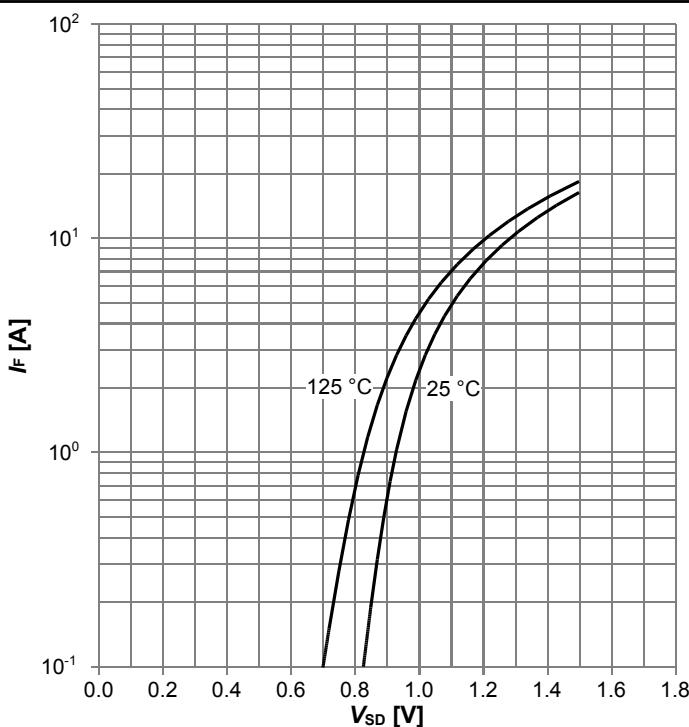
$I_D=f(V_{GS})$ ;  $V_{DS}=20\text{V}$ ; parameter:  $T_j$

**Diagram 10: Typ. gate charge**



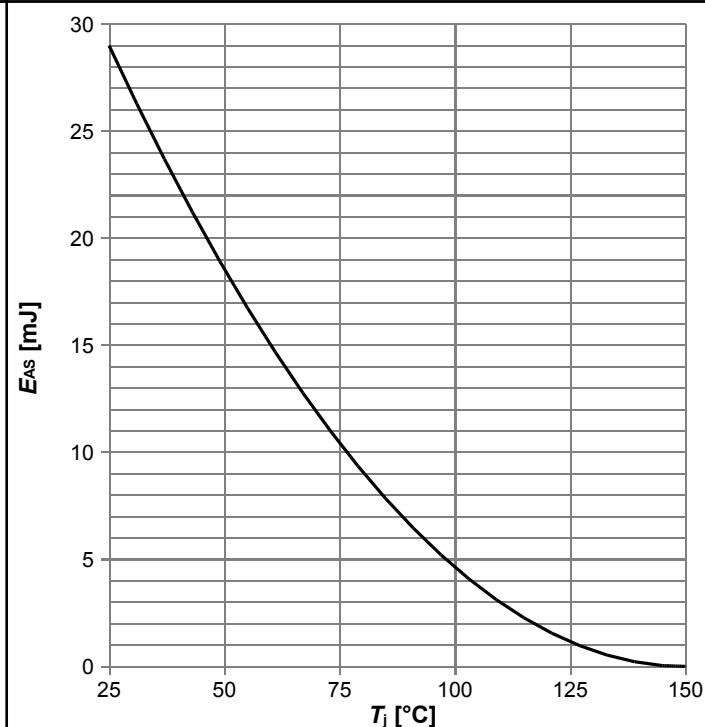
$V_{GS}=f(Q_{gate})$ ;  $I_D=2.9\text{ A}$  pulsed; parameter:  $V_{DD}$

**Diagram 11: Forward characteristics of reverse diode**



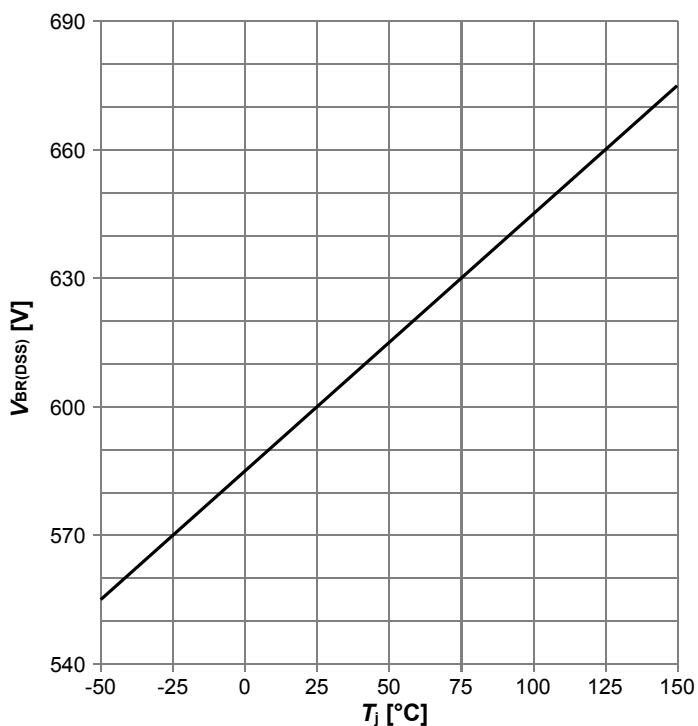
$I_F=f(V_{SD})$ ; parameter:  $T_j$

**Diagram 12: Avalanche energy**



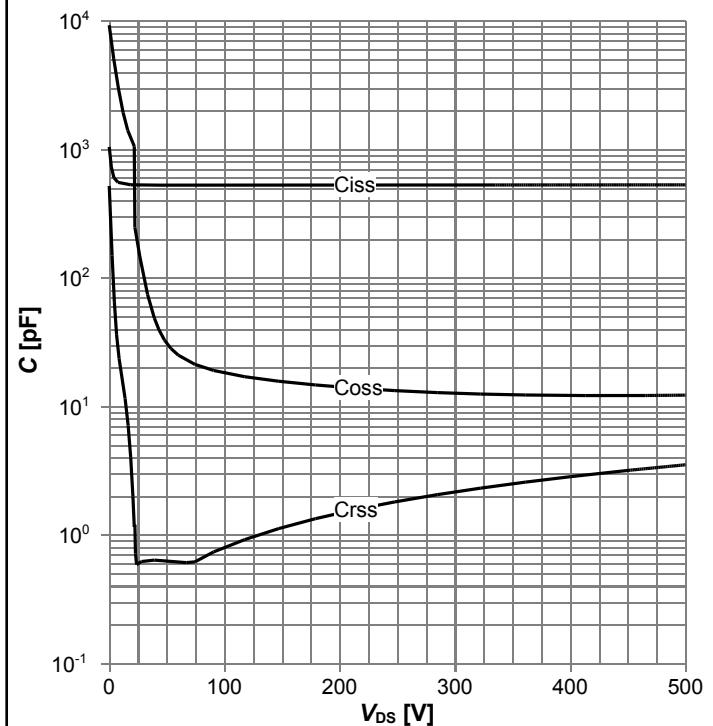
$E_{AS}=f(T_j)$ ;  $I_D=2.1\text{ A}$ ;  $V_{DD}=50\text{ V}$

**Diagram 13: Drain-source breakdown voltage**



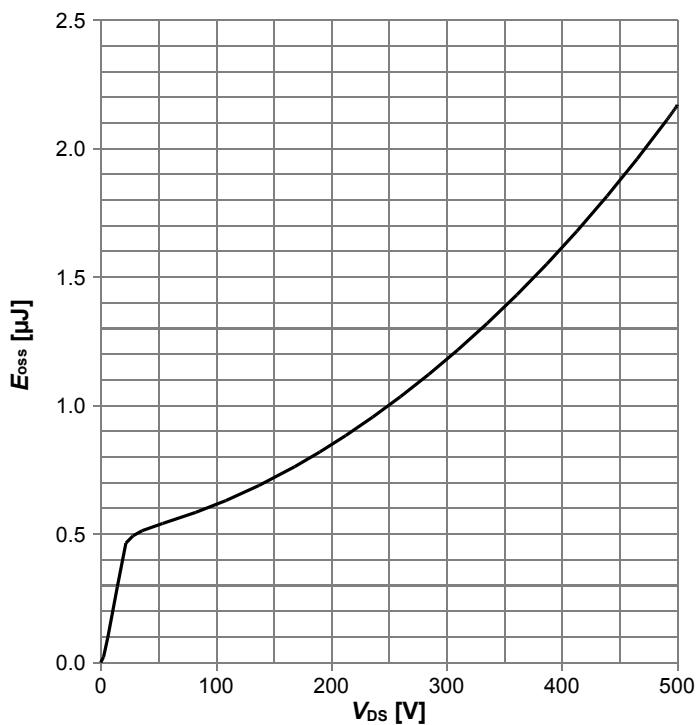
$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$

**Diagram 14: Typ. capacitances**



$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 250 \text{ kHz}$

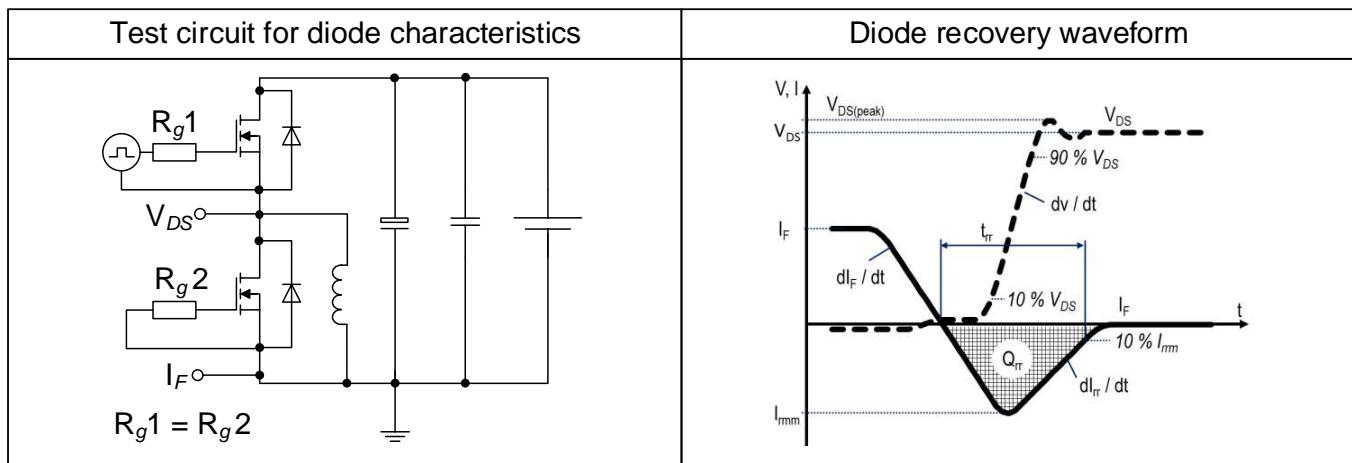
**Diagram 15: Typ. Coss stored energy**



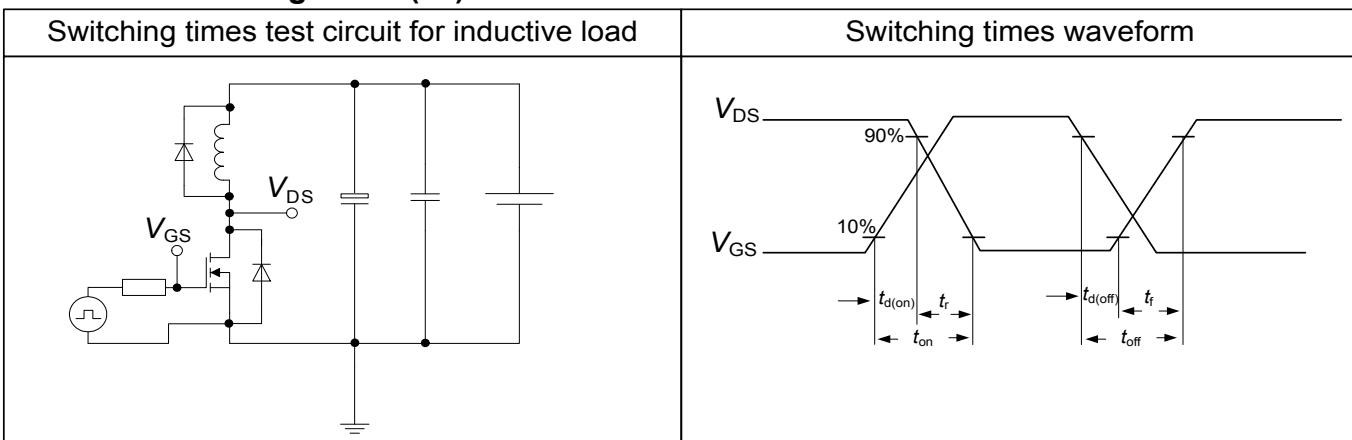
$E_{oss} = f(V_{DS})$

## 5 Test Circuits

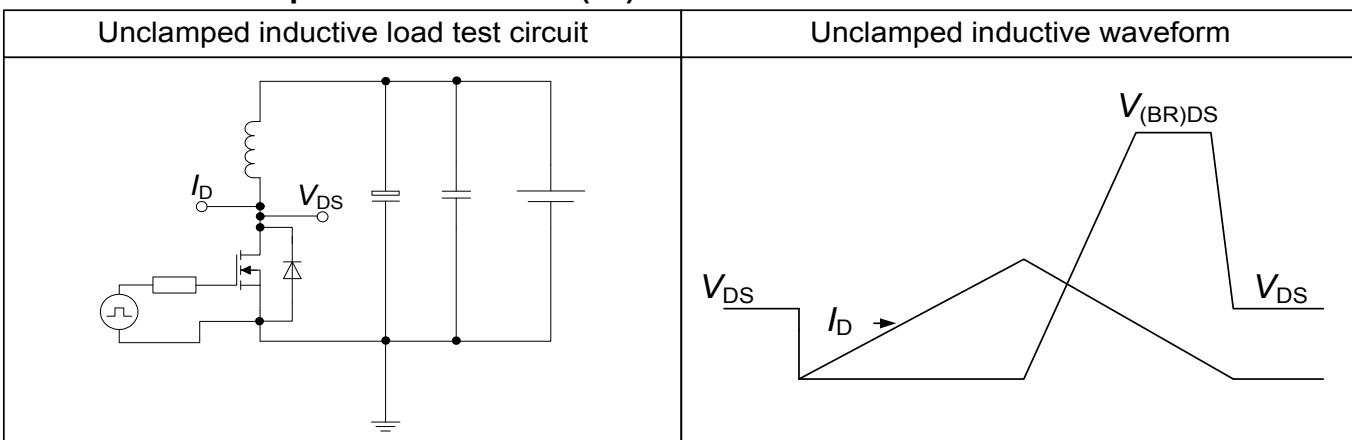
**Table 8 Diode characteristics**



**Table 9 Switching times (ss)**



**Table 10 Unclamped inductive load (ss)**



## 6 Package Outlines

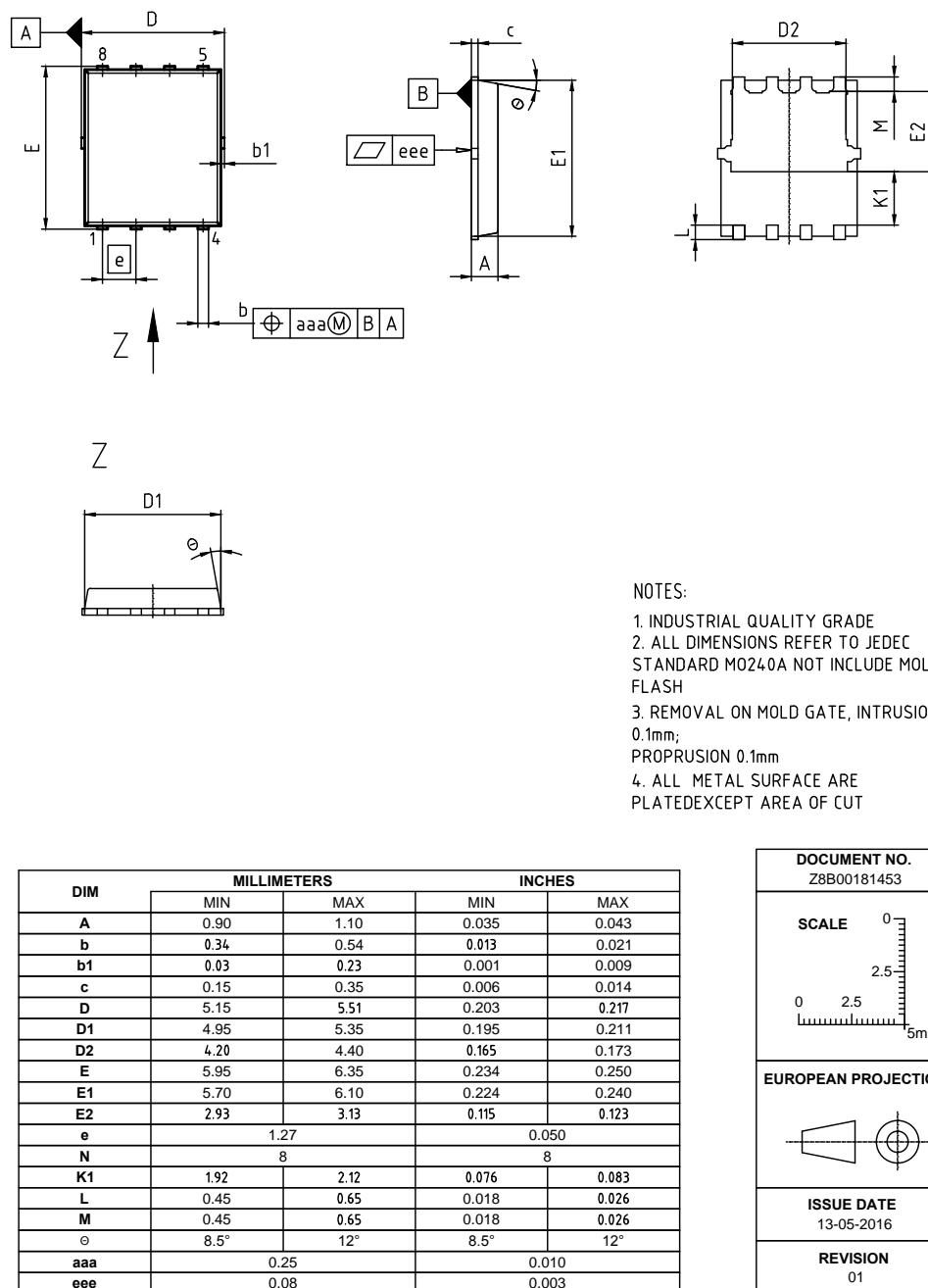


Figure 1 Outline ThinPAK 5x6 SMD, dimensions in mm/inches

## 7 Appendix A

### Table 11 Related Links

- **IFX CoolMOS PFD7 Webpage:** [www.infineon.com](http://www.infineon.com)
- **IFX CoolMOS PFD7 application note:** [www.infineon.com](http://www.infineon.com)
- **IFX CoolMOS PFD7 simulation model:** [www.infineon.com](http://www.infineon.com)
- **IFX Design tools:** [www.infineon.com](http://www.infineon.com)

## Revision History

IPLK60R360PFD7

**Revision: 2020-01-22, Rev. 2.0**

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2020-01-22	Release of final version

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